


<b>Search Notes</b>  	<b>Application/Control No.</b>  10827260	<b>Applicant(s)/Patent Under Reexamination</b>  HOSOKAWA, TAISUKE
	<b>Examiner</b>  Flores, Leon	<b>Art Unit</b>  2611

SEARCHED			
Class	Subclass	Date	Examiner
375	344	4/20/2007	LF
375	371	4/23/2007	LF

SEARCH NOTES		
Search Notes	Date	Examiner
Consulted with SPE David Payne in regards to the patentability of the claims.	4/20/2007	LF
Search in NPL (IEEE)	4/20/2007	LF
Checked for double patenting	4/20/2007	LF
Consulted with SPE David Payne in regards to the amendment.	10/26/2007	LF
Consulted with SPE David Payne in regards to the references used to reject the claims.	4/3/2008	LF

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
375	344	10/9/2008	LF